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1 Supporting information



Figure S 1: Ts profile and elemental fluxes during the deposition (dep.) of AGS and CIGS
 thin-films.



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Figure S 2: SEM cross-sections for (a) 45 nm, (b) 90 nm, and (c) 135 nm thick AGS layer on
SLG. (Given scale in the right lower corner of each image is 200 nm.)



- 10 Figure S 3: SEM surface and cross-sectional image for (a,d) 380 nm CIGS with 45 nm AGS
- 11 layer, (b,e)380 nm CIGS with 90 nm AGS layer, and (c,f) 380 nm CIGS with 135 nm AGS layer.



Figure S 4: Nanowires growth on the surface of thick AgGa precursor layer upon
 sulfurization.



16 Figure S 5: (a) TEM image and (b) EDS spectrum of a nanowire attached to Cu mesh wire.



Figure S 6: hU versus [hU x ln(1-EQE)]² plot for Ref and modified CIGS solar cell.



20 Figure S 7: JV curves for Ref and modified CIGS under standard AM1.5 illumination.